Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/792,171	APARIN ET AL.	
Examiner	Art Unit	
Tuen H. Nauven	2619	

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Class	Subclass	Date	Examiner
455	83,115.1	9/8/2006	T.N
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
All searches are on EAST data base and been consulted with Lee Nguyen.	9/8/2006	T.N
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